

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/054,512	BESHAI ET AL.	
Examiner	Art Unit	
Steven Blount	2668	

	SEAR	CHED	
Class	Subclass	Date	Examiner
320	230	1/10/05	SP
	231		
	232		
	236		
	235		
V	246	V	Y
320	22.9	11/10/05	54
		. /	,
-			

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		,		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
	_		
•			